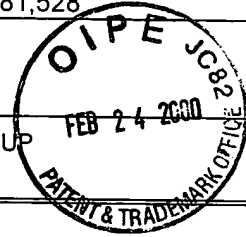


FORM PTO-1449 (Rev. 2-32) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE Information Disclosure Statement by Applicant (Use several sheets if necessary)	ATTY. DOCKET NO. YAO-V04302	SERIAL NO 09/381,528
	Applicant Yoshinao Taketomi et al.	
	FILING DATE January 4, 2000	GROUP



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Exmr Initial	Document Number	Date	Country	Class	Sub Class	Translation YES NO
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bc	62-63983	03/20/1987	Japan (with English abstract)			
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bc	1)	International Search Report dated July 28, 1998 for related application PCT/JP98/01148
bc	2)	Yoshinao Taketomi et al., "Reflection hologram for reconstructing deep images", OPTICS LETTERS, Vol. 22, No. 22, November 15, 1997
bc	3)	Yoshinao Taketomi et al., "Deep image reconstruction of a reflection hologram using a fluorescent lamp", 9 pages
bc	4)	"Report on Research and Study on Development of Large-Scale Hologram System (in Japanese)", Tokyo, Issued by Japan Society for the Promotion of Machine Industry Shin-Kikai System Center, March 1978, Page 116, lines 7-9; Figs 4.4.4
bc	5)	Yoshinao Taketomi et al., "A hologram that can reconstruct deep images, OPTICS JAPAN 97, 10/1/1997

Examiner 	Date Considered 10-11-2000
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Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.